

SAMPLE

検査成績表
<TEST REPORT>HIOKI
HIOKI E.E. CORPORATION

1/1

品名<Model Name> (アナログユニット<ANALOG UNIT>)
形名<Model Number> (8936)
製造番号<Serial No.> (No 120123465)
検査年月日<Test Date> (2012-05-02)
(<YYYY-MM-DD>)
検査条件<Test Conditions> (23 °C, 50 %rh)
電源周波数<Supply Frequency> (60Hz)

項目 <Item>	レンジ<Range>		検査点 <Test Point>	許容範囲 <Tolerance>	測定値<Measured Value>	
	A	B			CH-1	CH-2

1.ゼロポジション確度<Zero Position Accuracy>(ADJ ON)

*1 100 mV/DIV 50 mV/DIV 0 mV ± 1.00 mV (0.63 mV) (-0.63 mV)

2.DC振幅確度<DC Amplitude Accuracy>

10 mV/DIV	5 mV/DIV	100 mV ±	0.40 mV	(100.00 mV)	(100.00 mV)
20 mV/DIV	10 mV/DIV	200 mV ±	0.80 mV	(200.00 mV)	(199.90 mV)
50 mV/DIV	-	500 mV ±	2.0 mV	(500.3 mV)	(499.7 mV)
100 mV/DIV	50 mV/DIV	1 V ±	0.0040 V	(1.0000 V)	(0.9994 V)
200 mV/DIV	100 mV/DIV	2 V ±	0.0080 V	(2.0000 V)	(1.9990 V)
-	200 mV/DIV	4 V ±	0.0160 V	(4.0000 V)	(3.9970 V)
1 V/DIV	500 mV/DIV	10 V ±	0.040 V	(9.994 V)	(9.994 V)
2 V/DIV	1 V/DIV	20 V ±	0.080 V	(19.990 V)	(19.990 V)
-	2 V/DIV	40 V ±	0.160 V	(40.000 V)	(39.950 V)
10 V/DIV	5 V/DIV	100 V ±	0.40 V	(99.94 V)	(99.94 V)
20 V/DIV	10 V/DIV	200 V ±	0.80 V	(199.90 V)	(199.70 V)
50 V/DIV	-	400 V ±	2.0 V	(400.0 V)	(399.7 V)

備考<Note>

レンジA: 8835, 8835-01 <Range A: for Models 8835, 8835-01>

レンジB: 8826, 8841, 8842, 8720, 8860, 8860-50, 8861, 8861-50

<Range B: for Models 8826, 8841, 8842, 8720, 8860, 8860-50, 8861, 8861-50>

*1 ゼロポジション確度は、入力結合(カップリング)GNDにて校正しています。入力結合(カップリング)GNDとは内部回路で入力とGNDを短絡することです。<The accuracy of the zero position is calibrated by coupling GND. Coupling GND means to short input and GND at the inner circuit.>

FAIL判定箇所は、グレー表示としています。<FAIL decision points are highlighted in gray.>

総合判定<Overall Result>	検査者<Inspected By>	承認者<Approved By>
(PASS)	()	()

No.8936-14